

Search Notes

Application/Control No.

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Examiner

Hai V. Nguyen

Applicant(s)/Patent under
Reexamination

MARTIN ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
709	219	10/5/2006	HN
705	52	10/5/2006	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
709	219	10/5/2006	HN
705	52	10/5/2006	HN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search updated (US-PGPUB; USPAT; USOCR; EPO, JPO, DERWENT; IBM_TDB) (see search history printout report)	10/5/2006	HN
Limited classified search: 709/219; 705/52 (see search history printout report)	10/5/2006	HN
Interference search (see search history printout report)	10/5/2006	HN